Investigation of excitation dynamics in HfO2 and SiO2 monolayers using subpicosecond pump-and-probe damage testing (Withdrawal Notice)

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Proceedings Volume 11514, Laser-induced Damage in Optical Materials 2020; 1151411 (2020) https://doi.org/10.1117/12.2571240

Event: SPIE Laser Damage, 2020, Online Only

Online Publication Date: 11 September 2020 Withdrawn from Publication: 18 September 2020

Publisher's Note: This presentation, originally published on 11 September 2020, was withdrawn per author request.